

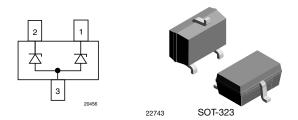
Vishay Semiconductors

HALOGEN

FREE GREEN

(5-2008)

Dual-Line ESD-Protection Diode Array in SOT-323

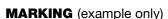


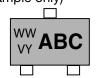
FEATURES

- Compact SOT-323 package
- 2-line unidirectional ESD-protection
- AEC-Q101 qualified available
- Working range 1 V to 33 V
- ESD immunity acc. IEC 61000-4-2 ±15 kV to ±30 kV contact discharge ±15 kV to ±30 kV air discharge



- soldering can be checked by standard vision inspection
- AOI = Automated Optical Inspection
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>





ABC = type code (see table below) WW = date code working week VY = date code year

LINKS TO ADDITIONAL RESOURCES



ORDERING INFORMATION					
		ENVIRONM	IENTAL AND QUAL	ITY CODE	
PART NUMBER (EXAMPLE)	AEC-Q101 QUALIFIED	RoHS COMPLIANT + LEAD (Pb)-FREE TERMINATIONS	TIN PLATED	3K PER 7" REEL (8 mm TAPE)	ORDERING CODE (EXAMPLE)
		GREEN		15K = MOQ	
VESD05A2-03G	-	G	3	-08	VESD05A2-03G-G3-08
VESD05A2-03G	Н	G	3	-08	VESD05A2-03GHG3-08

PACKAGE DATA																		
DEVICE NAME	PACKAGE NAME	TYPE CODE	WEIGHT	MOLDING COMPOUND FLAMMABILITY RATING	MOISTURE SENSITIVITY LEVEL	SOLDERING CONDITIONS												
VESD01A2-03G-G3	SOT-323	D01																
VESD03A2-03G-G3	SOT-323	D03	ı															
VESD05A2-03G-G3	SOT-323	D05																
VESD08A2-03G-G3	SOT-323	D08	5.2 mg	5.2 mg	5.2 mg	111 04 1/ 0	MSL level 1	Book tomporature may 260 °C										
VESD12A2-03G-G3	SOT-323	D12				5.2 mg	3.2 mg	3.2 mg	3.2 mg	3.2 mg	3.2 mg	3.2 mg	3.2 mg	3.2 mg	5.2 mg	5.2 mg	5.2 mg	UL 94 V-0 (according J-STD-020
VESD16A2-03G-G3	SOT-323	D16																
VESD26A2-03G-G3	SOT-323	D26																
VESD33A2-03G-G3	SOT-323	D33																

VESD01A2-03G to VESD33A2-03G

ABSOLUTE MAXIMUM RATINGS VESD01A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)					
PARAMETER	TEST CONDITIONS	SYMBOL	VALUE	UNIT	
Peak pulse current	Acc. IEC 61000-4-5, 8/20 μs/single shot	I _{PPM}	11	Α	
Peak pulse power	Acc. IEC 61000-4-5, 8/20 μs/single shot	P _{PP}	70	W	
ESD immunity	Contact discharge acc. IEC 61000-4-2; 10 pulses	V	30	kV	
E3D IIIIIIIIIIIIII	Air discharge acc. IEC 61000-4-2; 10 pulses	V_{ESD}	30	kV	
Operating temperature	Junction temperature	T _J	-55 to +150	°C	
Storage temperature		T _{stg}	-55 to +150	°C	

ABSOLUTE MAXIMUM RATINGS VESD03A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)					
PARAMETER	TEST CONDITIONS	SYMBOL	VALUE	UNIT	
Peak pulse current	Acc. IEC 61000-4-5, 8/20 μs/single shot	I _{PPM}	11.6	Α	
Peak pulse power	Acc. IEC 61000-4-5, 8/20 μs/single shot	P _{PP}	100	W	
CCD immunity	Contact discharge acc. IEC 61000-4-2; 10 pulses	V	30	kV	
ESD immunity	Air discharge acc. IEC 61000-4-2; 10 pulses	V_{ESD}	30	kV	
Operating temperature	Junction temperature	TJ	-55 to +150	°C	
Storage temperature		T _{stg}	-55 to +150	°C	

ABSOLUTE MAXIMUM RATINGS VESD05A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)					
PARAMETER	TEST CONDITIONS	SYMBOL	VALUE	UNIT	
Peak pulse current	Acc. IEC 61000-4-5, 8/20 μs/single shot	I _{PPM}	8.7	Α	
Peak pulse power	Acc. IEC 61000-4-5, 8/20 μs/single shot	P _{PP}	100	W	
CCD immunity	Contact discharge acc. IEC 61000-4-2; 10 pulses	\/	30	kV	
ESD immunity	Air discharge acc. IEC 61000-4-2; 10 pulses	V_{ESD}	30	kV	
Operating temperature	Junction temperature	T _J	-55 to +150	°C	
Storage temperature		T _{stg}	-55 to +150	°C	

ABSOLUTE MAXIMUM RATINGS VESD08A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)						
PARAMETER	TEST CONDITIONS	SYMBOL	VALUE	UNIT		
Peak pulse current	Acc. IEC 61000-4-5, 8/20 μs/single shot	I _{PPM}	6.60	А		
Peak pulse power	Acc. IEC 61000-4-5, 8/20 μs/single shot	P _{PP}	100	W		
CCD immunity	Contact discharge acc. IEC 61000-4-2; 10 pulses	V	30	kV		
ESD immunity	Air discharge acc. IEC 61000-4-2; 10 pulses	V_{ESD}	30	kV		
Operating temperature	Junction temperature	TJ	-55 to +150	°C		
Storage temperature		T _{stg}	-55 to +150	°C		

VESD01A2-03G to VESD33A2-03G

ABSOLUTE MAXIMUM RATINGS VESD12A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)						
PARAMETER	TEST CONDITIONS	SYMBOL	VALUE	UNIT		
Peak pulse current	Acc. IEC 61000-4-5, 8/20 μs/single shot	I _{PPM}	4.4	Α		
Peak pulse power	Acc. IEC 61000-4-5, 8/20 μs/single shot	P _{PP}	100	W		
ESD immunity	Contact discharge acc. IEC 61000-4-2; 10 pulses	V	30	kV		
E3D IIIIIIIIIIIIII	Air discharge acc. IEC 61000-4-2; 10 pulses	V_{ESD}	30	kV		
Operating temperature	Junction temperature	T _J	-55 to +150	°C		
Storage temperature		T _{stg}	-55 to +150	°C		

ABSOLUTE MAXIMUM RATINGS VESD16A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)					
PARAMETER	TEST CONDITIONS	SYMBOL	VALUE	UNIT	
Peak pulse current	Acc. IEC 61000-4-5, 8/20 μs/single shot	I _{PPM}	3.6	Α	
Peak pulse power	Acc. IEC 61000-4-5, 8/20 μs/single shot	P _{PP}	100	W	
ESD immunity	Contact discharge acc. IEC 61000-4-2; 10 pulses	V	30	kV	
E3D IIIIIIuriity	Air discharge acc. IEC 61000-4-2; 10 pulses	V_{ESD}	30	kV	
Operating temperature	Junction temperature	T _J	-55 to +150	°C	
Storage temperature		T _{stg}	-55 to +150	°C	

ABSOLUTE MAXIMUM RATINGS VESD26A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)					
PARAMETER	TEST CONDITIONS	SYMBOL	VALUE	UNIT	
Peak pulse current	Acc. IEC 61000-4-5, 8/20 μs/single shot	I _{PPM}	2.1	Α	
Peak pulse power	Acc. IEC 61000-4-5, 8/20 μs/single shot	P _{PP}	100	W	
CCD immunity	Contact discharge acc. IEC 61000-4-2; 10 pulses	V	20	kV	
ESD immunity	Air discharge acc. IEC 61000-4-2; 10 pulses	V_{ESD}	20	kV	
Operating temperature	Junction temperature	TJ	-55 to +150	°C	
Storage temperature		T _{stg}	-55 to +150	°C	

ABSOLUTE MAXIMUM RATINGS VESD33A2-03G T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)					
PARAMETER	TEST CONDITIONS	SYMBOL	VALUE	UNIT	
Peak pulse current	Acc. IEC 61000-4-5, 8/20 μs/single shot	I _{PPM}	1.6	Α	
Peak pulse power	Acc. IEC 61000-4-5, 8/20 μs/single shot	P_{PP}	100	W	
ESD immunity	Contact discharge acc. IEC 61000-4-2; 10 pulses	V	15	kV	
E3D Infinitrity	Air discharge acc. IEC 61000-4-2; 10 pulses	V_{ESD}	15	kV	
Operating temperature	Junction temperature	T _J	-55 to +150	°C	
Storage temperature		T _{stg}	-55 to +150	°C	



ELECTRICAL CHARACTERISTICS VESD01A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)						
PARAMETER	TEST CONDITIONS/REMARKS	SYMBOL	MIN.	TYP.	MAX.	UNIT
Protection paths	Number of lines which can be protected	N _{channel}	-	-	2	lines
Reverse stand off voltage	Max. reverse working voltage	V_{RWM}	-	-	1	V
Reverse voltage	at I _R = 100 μA	V_R	1	1.2	-	V
Reverse current	at V _R = 1 V	I _R	-	20	100	μΑ
Reverse breakdown voltage	at I _R = 20 mA	V_{BR}	2.5	2.65	2.8	V
Reverse clamping voltage	at $I_{PP} = I_{PPM} = 11 \text{ A}, t_p = 8/20 \mu\text{s}$	V _C	-	5.6	6.4	V
Converd elemning veltage	at I _{PP} = 1 A, t _p = 300 μs	V _F	0.9	1.1	1.2	V
Forward clamping voltage	at I _{PP} = I _{PPM} = 11 A, t _p = 8/20 μs	V _F	-	2.5	3.2	V
Dynamic resistance	t _p = 100 ns (TLP; reverse direction)	r _{dyn}	-	0.13	-	Ω
Capacitance	at V _R = 0 V; f = 1 MHz	C_D	153	192	230	pF

ELECTRICAL CHARACTERISTICS VESD03A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)						
PARAMETER	TEST CONDITIONS/REMARKS	SYMBOL	MIN.	TYP.	MAX.	UNIT
Protection paths	Number of lines which can be protected	N _{channel}	-	-	2	lines
Reverse stand off voltage	Max. reverse working voltage	V_{RWM}	-	-	3	V
Reverse voltage	at I _R = 20 μA	V_R	3	-	-	V
Reverse current	at V _R = 3 V	I _R	-	8	20	μA
Reverse breakdown voltage	at I _R = 1 mA	V_{BR}	4.4	4.65	4.9	V
Reverse clamping voltage	at $I_{PP} = I_{PPM} = 11.6 \text{ A}, t_p = 8/20 \mu \text{s}$	V _C	-	7.8	8.70	V
Converd elemping veltage	at $I_{PP} = 1 \text{ A}, t_p = 300 \mu s$	V_{F}	0.9	1.1	1.2	V
Forward clamping voltage	at I _{PP} = I _{PPM} = 11.6 A, t _p = 8/20 μs	V _F	-	2.6	3.32	V
Dynamic resistance	t _p = 100 ns (TLP; reverse direction)	r _{dyn}	-	0.19	-	Ω
Capacitance	at V _R = 0 V; f = 1 MHz	C _D	89	112	135	pF

ELECTRICAL CHARACTERISTICS VESD05A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)							
PARAMETER	TEST CONDITIONS/REMARKS	SYMBOL	MIN.	TYP.	MAX.	UNIT	
Protection paths	Number of lines which can be protected	N _{channel}	-	-	2	lines	
Reverse stand off voltage	Max. reverse working voltage	V_{RWM}	-	-	5	V	
Reverse voltage	at I _R = 1 μA	V_R	5	-	-	V	
Reverse current	at V _R = 5 V	I _R	-	0.01	0.1	μΑ	
Reverse breakdown voltage	at I _R = 1 mA	V_{BR}	6.85	7.26	7.65	V	
Reverse clamping voltage	at $I_{PP} = I_{PPM} = 8.7 \text{ A}, t_p = 8/20 \mu \text{s}$	V _C	-	10.3	11.5	V	
Famuard alamaina valtaga	at I _{PP} = 1 A, t _p = 300 μs	V _F	0.9	1.1	1.2	V	
Forward clamping voltage	at $I_{PP} = I_{PPM} = 8.7 \text{ A}, t_p = 8/20 \mu\text{s}$	V_{F}	-	2.2	2.74	V	
Dynamic resistance	t _p = 100 ns (TLP; reverse direction)	r _{dyn}	-	0.2	-	Ω	
Capacitance	at $V_R = 0 V$; $f = 1 MHz$	C _D	53	67	81	pF	



ELECTRICAL CHARACTERISTICS VESD08A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)						
PARAMETER	TEST CONDITIONS/REMARKS	SYMBOL	MIN.	TYP.	MAX.	UNIT
Protection paths	Number of lines which can be protected	N _{channel}	-	-	2	lines
Reverse stand off voltage	Max. reverse working voltage	V_{RWM}	-	-	8	V
Reverse voltage	at I _R = 0.1 μA	V_R	8	-	-	V
Reverse current	at V _R = 8 V	I _R	-	0.01	0.1	μΑ
Reverse breakdown voltage	at I _R = 1 mA	V_{BR}	9.5	10	10.5	V
Reverse clamping voltage	at $I_{PP} = I_{PPM} = 6.6 \text{ A}$, $t_p = 8/20 \mu\text{s}$	V _C	-	13.7	15.3	V
Faruard alamaina valtaga	at I _{PP} = 1 A, t _p = 300 μs	V_{F}	0.9	1.1	1.2	V
Forward clamping voltage	at I _{PP} = I _{PPM} = 6.6 A, t _p = 8/20 μs	V_{F}	-	1.9	2.32	V
Dynamic resistance	t _p = 100 ns (TLP; reverse direction)	r _{dyn}	-	0.23	-	Ω
Capacitance	at $V_R = 0 V$; $f = 1 MHz$	C _D	37	47	57	pF

ELECTRICAL CHARACTERISTICS VESD12A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)							
PARAMETER	TEST CONDITIONS/REMARKS	SYMBOL	MIN.	TYP.	MAX.	UNIT	
Protection paths	Number of lines which can be protected	N _{channel}	-	-	2	lines	
Reverse stand off voltage	Max. reverse working voltage	V_{RWM}	-	-	12	V	
Reverse voltage	at I _R = 0.1 μA	V_R	12	-	-	V	
Reverse current	at V _R = 12 V	I _R	-	0.01	0.1	μA	
Reverse breakdown voltage	at I _R = 1 mA	V_{BR}	13.9	14.7	15.5	V	
Reverse clamping voltage	at $I_{PP} = I_{PPM} = 4.4 \text{ A}, t_p = 8/20 \mu s$	V _C	-	20.5	22.7	V	
Famusard alamaina valtaga	at $I_{PP} = 1 \text{ A}, t_p = 300 \mu s$	V_{F}	0.9	1.1	1.2	V	
Forward clamping voltage	at I _{PP} = I _{PPM} = 4.4 A, t _p = 8/20 μs	V _F	-	1.6	1.88	V	
Dynamic resistance	t _p = 100 ns (TLP; reverse direction)	r _{dyn}	-	0.4	-	Ω	
Capacitance	at $V_R = 0 V$; $f = 1 MHz$	C _D	26	33	40	pF	

ELECTRICAL CHARACTERISTICS VESD16A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)							
PARAMETER	TEST CONDITIONS/REMARKS	SYMBOL	MIN.	TYP.	MAX.	UNIT	
Protection paths	Number of lines which can be protected	N _{channel}	-	-	2	lines	
Reverse stand off voltage	Max. reverse working voltage	V_{RWM}	-	-	16	V	
Reverse voltage	at I _R = 0.1 μA	V_R	16	-	-	V	
Reverse current	at V _R = 16 V	I _R	-	0.01	0.1	μΑ	
Reverse breakdown voltage	at I _R = 1 mA	V_{BR}	17	17.9	18.8	V	
Reverse clamping voltage	at $I_{PP} = I_{PPM} = 3.6 \text{ A}, t_p = 8/20 \mu\text{s}$	V _C	-	25.3	28	V	
Famous de la serie a contra de	at I _{PP} = 1 A, t _p = 300 μs	V _F	0.9	1.1	1.2	V	
Forward clamping voltage	at I _{PP} = I _{PPM} = 3.6 A, t _p = 8/20 μs	V _F	-	1.5	1.72	V	
Dynamic resistance	t _p = 100 ns (TLP; reverse direction)	r _{dyn}	-	0.53	-	Ω	
Capacitance	at V _R = 0 V; f = 1 MHz	C _D	21	27	33	pF	



ELECTRICAL CHARACTERISTICS VESD26A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)							
PARAMETER	TEST CONDITIONS/REMARKS	SYMBOL	MIN.	TYP.	MAX.	UNIT	
Protection paths	Number of lines which can be protected	N _{channel}	-	-	2	lines	
Reverse stand off voltage	Max. reverse working voltage	V_{RWM}	-	-	26	V	
Reverse voltage	at I _R = 0.1 μA	V_R	26	-	-	V	
Reverse current	at V _R = 26 V	I _R	-	< 0.01	0.1	μA	
Reverse breakdown voltage	at I _R = 1 mA	V_{BR}	27.6	29.1	30.6	V	
Reverse clamping voltage	at $I_{PP} = I_{PPM} = 2.1 \text{ A}$, $t_p = 8/20 \mu\text{s}$	V _C	-	43	48	V	
Forward alamning valtage	at I _{PP} = 1 A, t _p = 300 μs	V _F	0.9	1.1	1.2	V	
Forward clamping voltage	at $I_{PP} = I_{PPM} = 2.1 \text{ A}$, $t_p = 8/20 \mu\text{s}$	V _F	-	1.3	1.42	V	
Dynamic resistance	t _p = 100 ns (TLP; reverse direction)	r _{dyn}	-	1.9	-	Ω	
Capacitance	at V _R = 0 V; f = 1 MHz	C _D	14	17.5	21	pF	

ELECTRICAL CHARACTERISTICS VESD33A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)							
PARAMETER	TEST CONDITIONS/REMARKS	SYMBOL	MIN.	TYP.	MAX.	UNIT	
Protection paths	Number of lines which can be protected	N _{channel}	-	-	2	lines	
Reverse stand off voltage	Max. reverse working voltage	V_{RWM}	-	-	33	V	
Reverse voltage	at I _R = 0.1 μA	V_R	33	-	-	V	
Reverse current	at V _R = 33 V	I _R	-	< 0.01	0.1	μΑ	
Reverse breakdown voltage	at I _R = 1 mA	V_{BR}	35.5	37.4	39.3	V	
Reverse clamping voltage	at $I_{PP} = I_{PPM} = 1.6 \text{ A}$, $t_p = 8/20 \mu\text{s}$	V _C	-	56	62.5	V	
Converd elemning veltage	at $I_{PP} = 1 \text{ A}$, $t_p = 300 \mu\text{s}$	V_{F}	0.9	1.1	1.2	V	
Forward clamping voltage	at I _{PP} = I _{PPM} = 1.6 A, t _p = 8/20 μs	V _F	-	1.22	1.32	V	
Dynamic resistance	t _p = 100 ns (TLP; reverse direction)	r _{dyn}	-	3.6	-	Ω	
Capacitance	at V _R = 0 V; f = 1 MHz	C_{D}	12	15	18	pF	

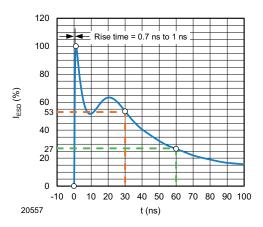


Fig. 1 - ESD Discharge Current Wave Form acc. IEC 61000-4-2 (330 Ω / 150 pF)

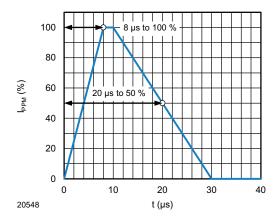


Fig. 2 - 8/20 µs Peak Pulse Current Wave Form acc. IEC 61000-4-5

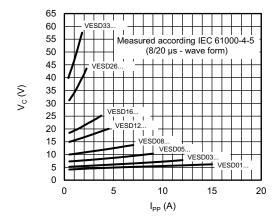


Fig. 3 - Typical Peak Clamping Voltage vs. Peak Pulse Current

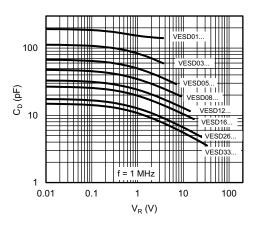


Fig. 4 - Typical Capacitance vs. Reverse Voltage

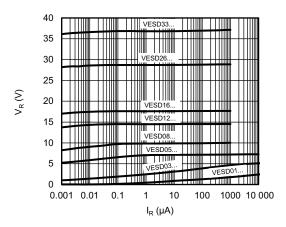


Fig. 5 - Typical Reverse Voltage vs. Reverse Current

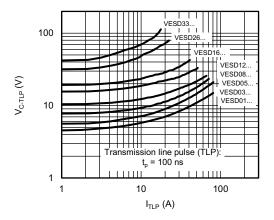


Fig. 6 - Typical Clamping Voltage vs. Peak Pulse Current

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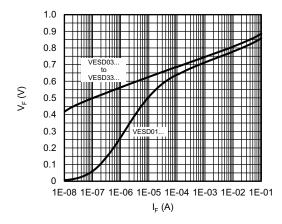


Fig. 7 - Typical Forward Voltage vs. Forward Current

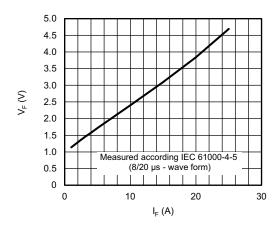
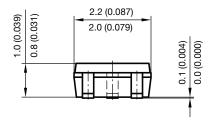
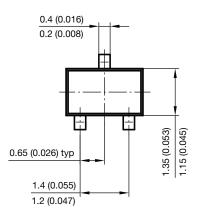


Fig. 8 - Typical Forward Voltage vs. Forward Current

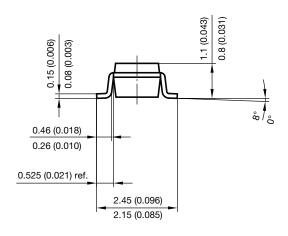
PACKAGE DIMENSIONS in millimeters (inches): SOT-323



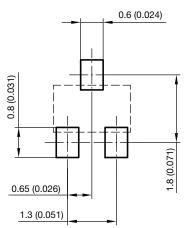


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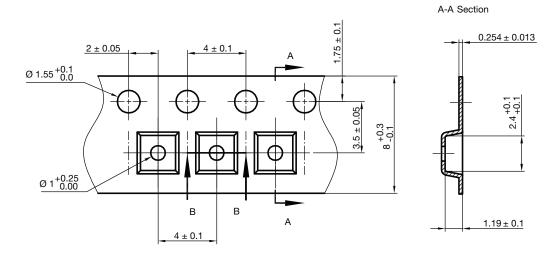
foot print recommendation:



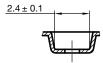


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CARRIER TAPE SOT-323

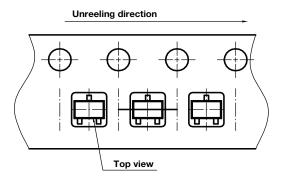


B-B Section



Document no.: S8-V-3717.08-002 (4) Created - Date: 09. Feb. 2010

ORIENTATION IN CARRIER TAPE SOT-323



Document no.: S8-V-3717.08-002 (4) Created - Date: 09. Feb. 2010

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